



# GENERAL ENGINEERING AND RESEARCH

National Science Foundation – SBIR Phase II

## Nano-Capsule CMP Slurries: Enabling Localized Control of Chemical Exposure

Robin V. Ihnfeldt, Ph.D.

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# Outline

- Introduction
  - GE&R Background
  - Motivation and Objective of Research
- Synthesis and Characterization
  - Silica particles
  - Nano-capsules
- CMP Experiments
  - MRR and Planarization Efficiency
- Other Efforts
- Summary
- Acknowledgements

# GE&R Background

- Founded in 2009

- Industry Experience – Semiconductor/ Pharmaceuticals/ Medical Device/ Oil refining
- PhD on CMP slurries
- Licensed Patent Agent
- GE&R Advisor Board
  - Ted Taylor - Micron R&D Fab Manager / Director at Cymer
  - Steve Oldenburg – President of NanoComposix
  - Professor Jan Talbot – Head of UCSD ChemE dept.

- Current employees

- 5 full time employees , 2 part time, 3 UCSD graduate students, 2 Prof.

- Lab opened in 2012 with Phase I SBIR NSF Grant - \$150,000 1yr

- Development of nano-Capsules
  - CMP slurries

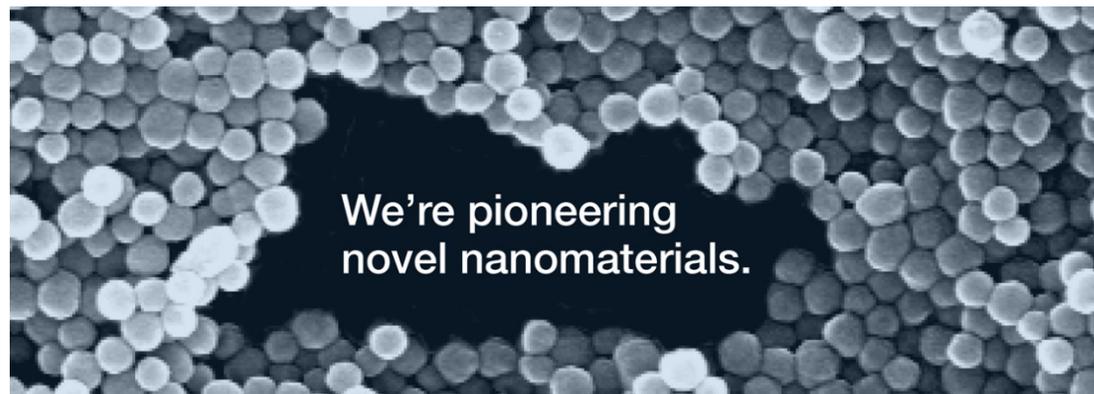
- Phase II Awarded 2014 - \$750,000 – 2yr

- R&D Grant NRL – \$2.4M for 6 yrs - Cooling Technology - Collaboration with UCSD

- DOE STTR Awarded June 2012 – Magnetocaloric nanomaterials

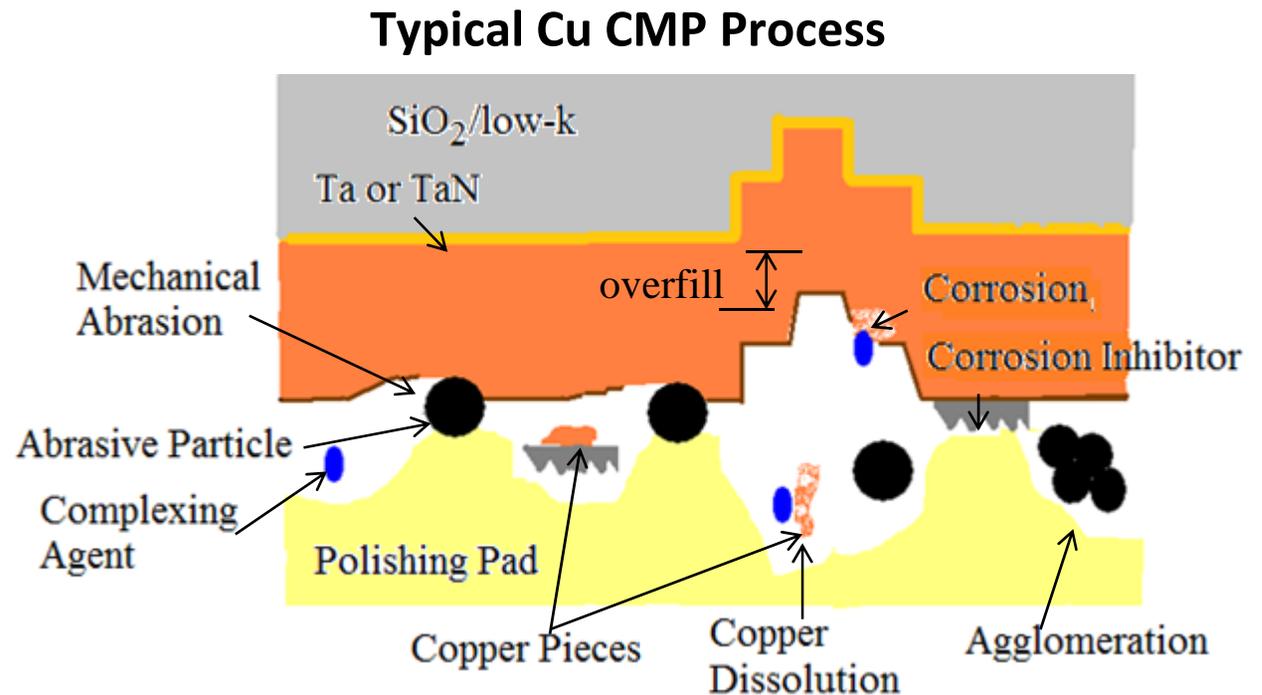
## Future Research Areas

- Bio applications - Nano-Capsules



# Motivation

- CMP - planarize and remove material
- Slurry - mechanical and chemical
- Cu CMP complex - reactive surface

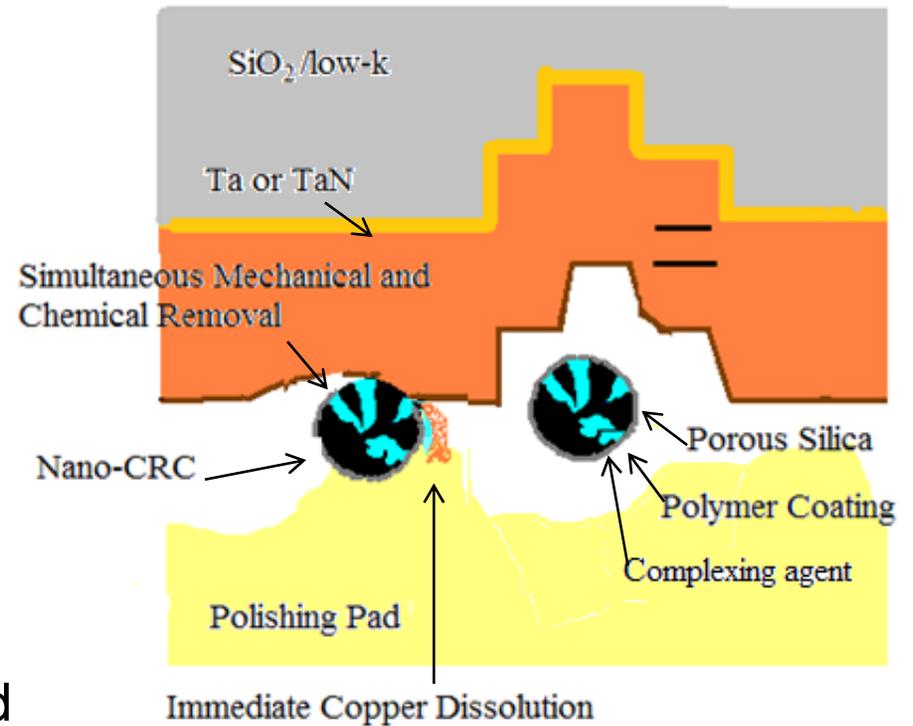


- Current CMP slurries are homogeneous mixtures of nanoparticles and chemicals
  - Chemicals - cause unwanted etching, dishing, oxidation
  - Additional corrosion inhibitors, surfactants – lower MRR
  - As devices scale down – becomes more difficult to achieve planarity
- Need to control exposure of the chemical components
  - reduce/eliminate etching, increase planarization efficiency

# Research Objectives

Develop and optimize methods to synthesize nano-capsule slurries

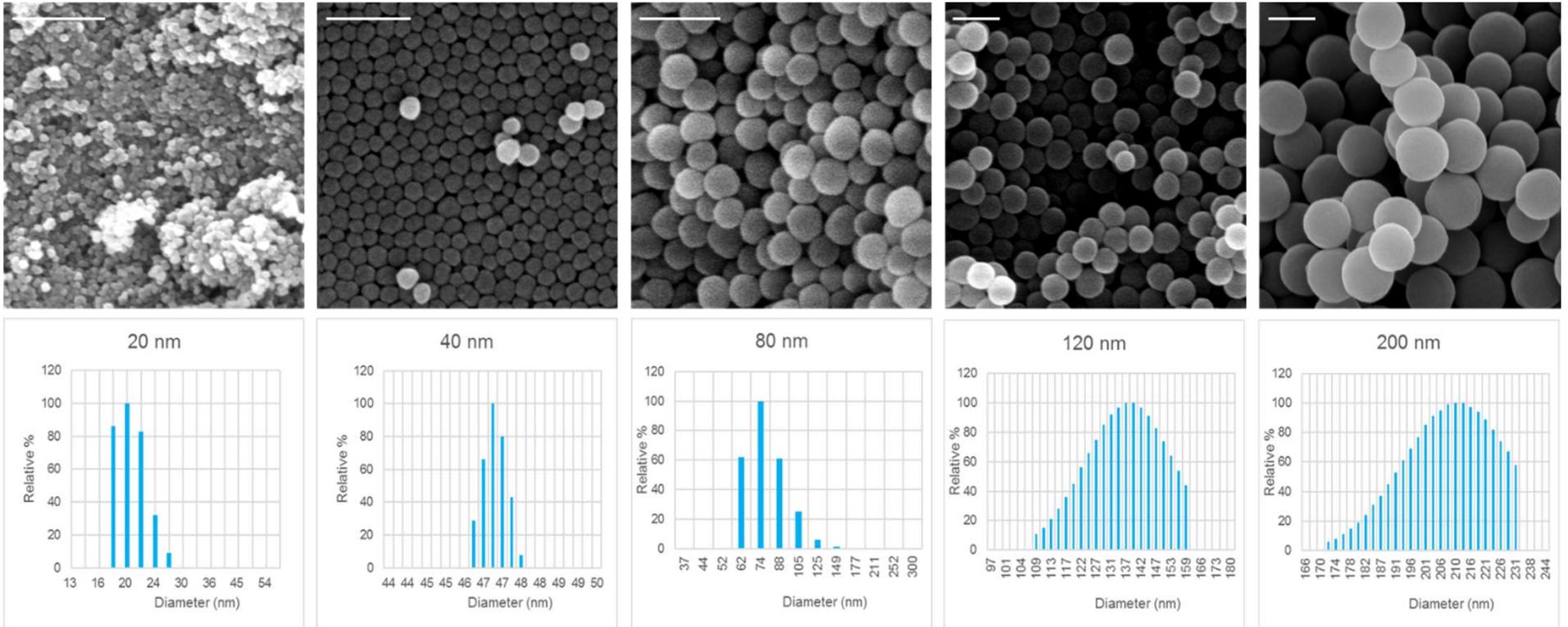
- ❑ Chemical payload encapsulated in the nanoparticle pores
- ❑ Polymer coating that is stable over time – does not allow leakage of payload
- ❑ A polymer soft enough to be torn away with shearing force to release the payload
- ❑ Particles that are easily dispersed – no agglomeration
- ❑ Meet the cost requirements for competitive CMP slurry pricing



For Cu CMP – silica loaded with glycine

- Zero etch rate,
- High MRR
- High PE

# Porous Silica Synthesis

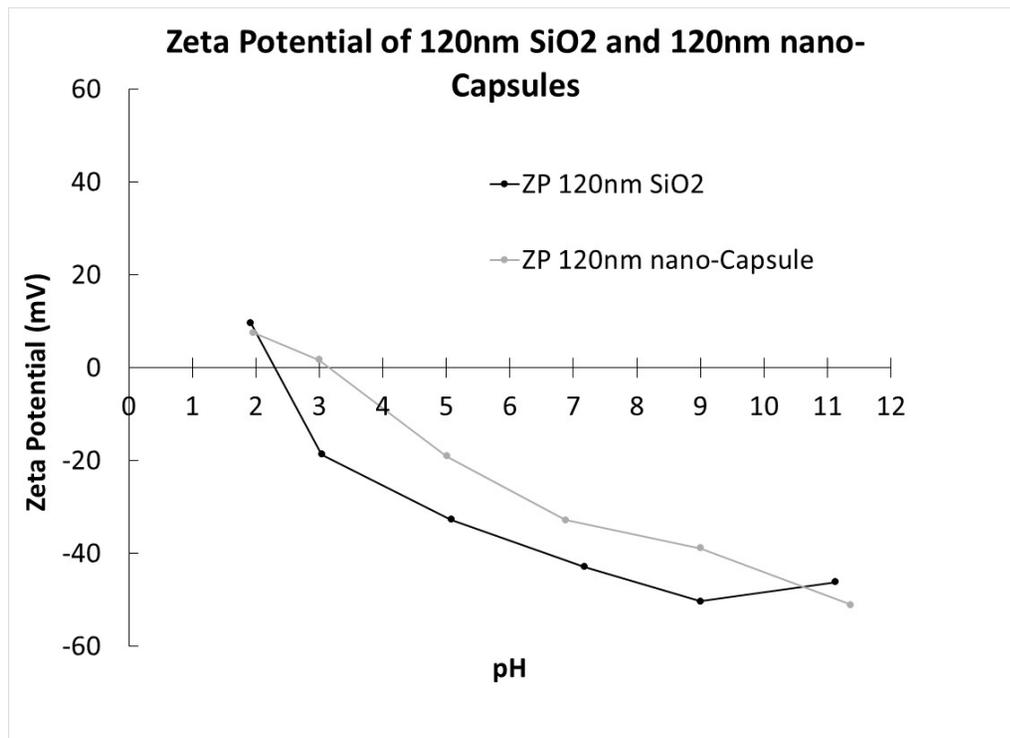


- Modified Stober method
- GE&R Silica is available from 20nm-1000nm
- $Cv < 20\%$  (SEM)
- Powder or dispersion

# Nano-capsule Synthesis

## GE&R Synthetic Methods Proprietary

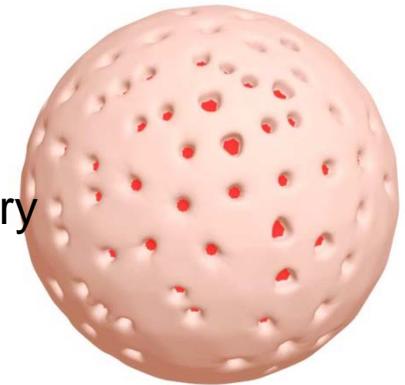
- Loading and coating is simultaneous in solution
- Economical Processing
- Various base particles (silica, alumina, etc.) possible
- Various payloads possible
- Considerations for nano-capsule synthesis
  - Solution pH, nanoparticle IEP, ionic strength, chemical payload interaction with polymer materials



Porous  
Nanoparticle



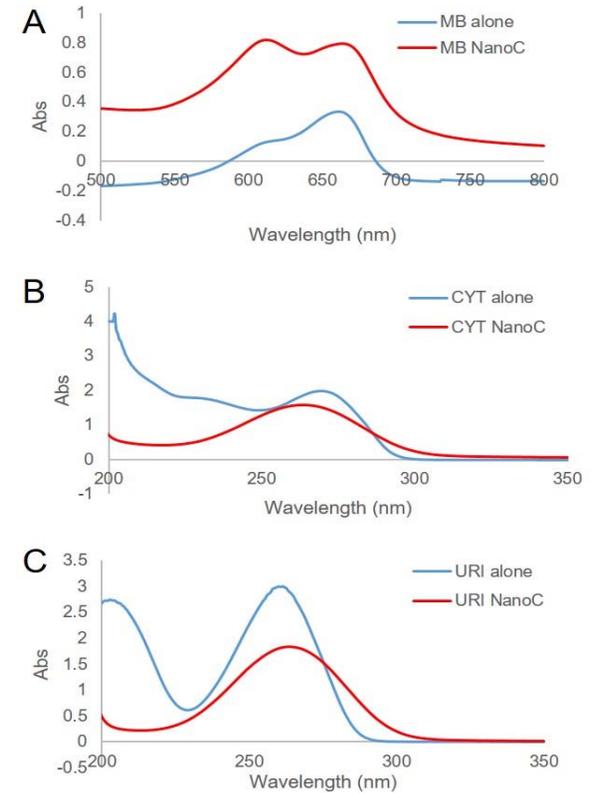
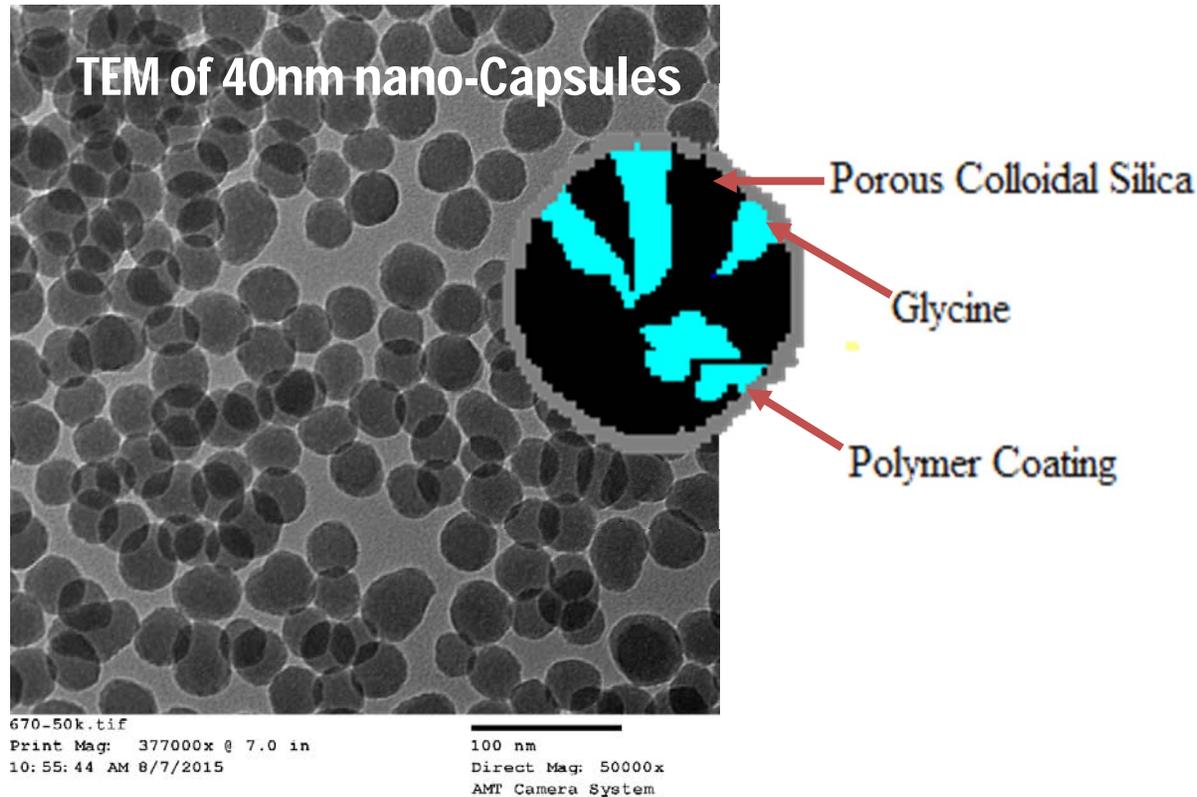
Load  
Chemistry



Polymer  
Encapsulation



# Nano-Capsule Loading



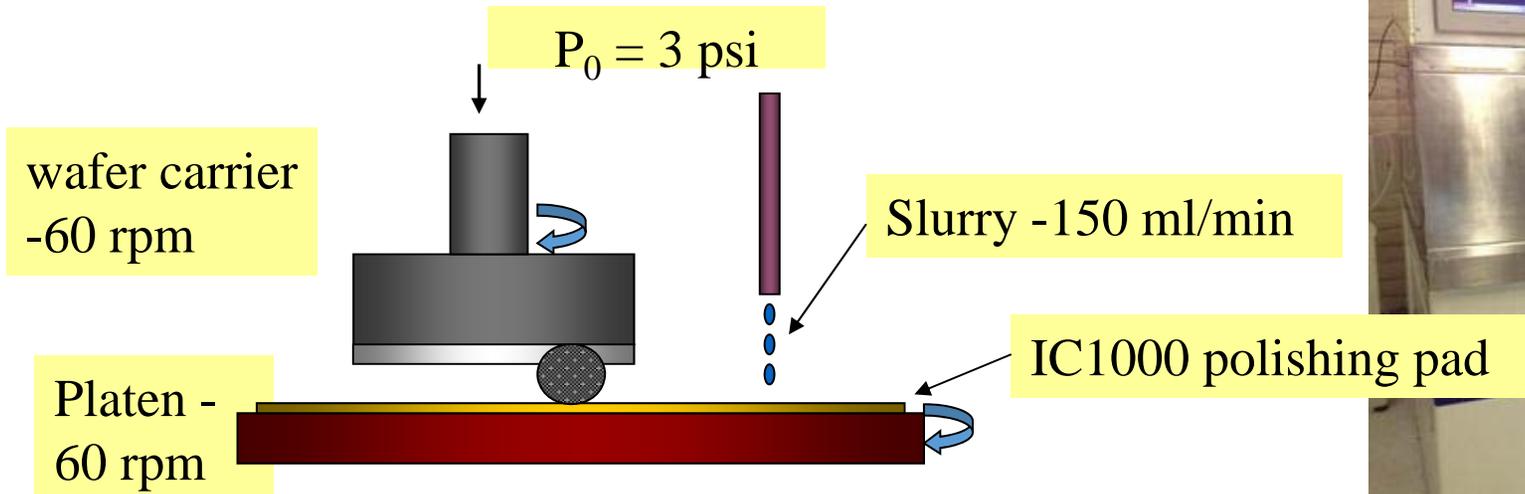
UV-Vis data of a) MB, b) CYT, and c) URI in solution alone and encapsulated into 40nm silica nano-capsules

How much chemical is loaded?

- BET intra - porosity 40nm silica ~ 15-20%
- Glycine + Methylene Blue ~3-15% loading
- Cytidine and Uridine ~3-5%
- Polymer coating not complete encapsulation?
- Pore Size effects

# Experimental Copper CMP

## Strasbaugh 6EC CMP Machine

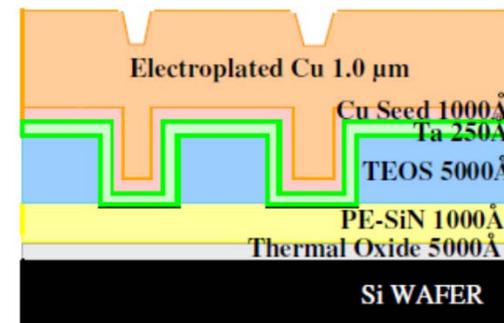


- Addition of hydrogen peroxide ( $H_2O_2$ ) (oxidizing agent)

Material Removal Rates (MRR) – wafers weighed before and after CMP

Planarization Efficiency (PE) – measured using a Dektak 150 surface profiler

- Test wafers were purchased from SKW Associates, Inc., using MIT854 mask



# Cu CMP Data

- Cu CMP of 6in blanket copper wafers on Strasbaugh 6EC CMP machine  
**Silica loaded with various concentrations of glycine.**  
**(silica at 4wt% and at pH 4.5 with 0.1wt% H<sub>2</sub>O<sub>2</sub>+1mM KNO<sub>3</sub>).**

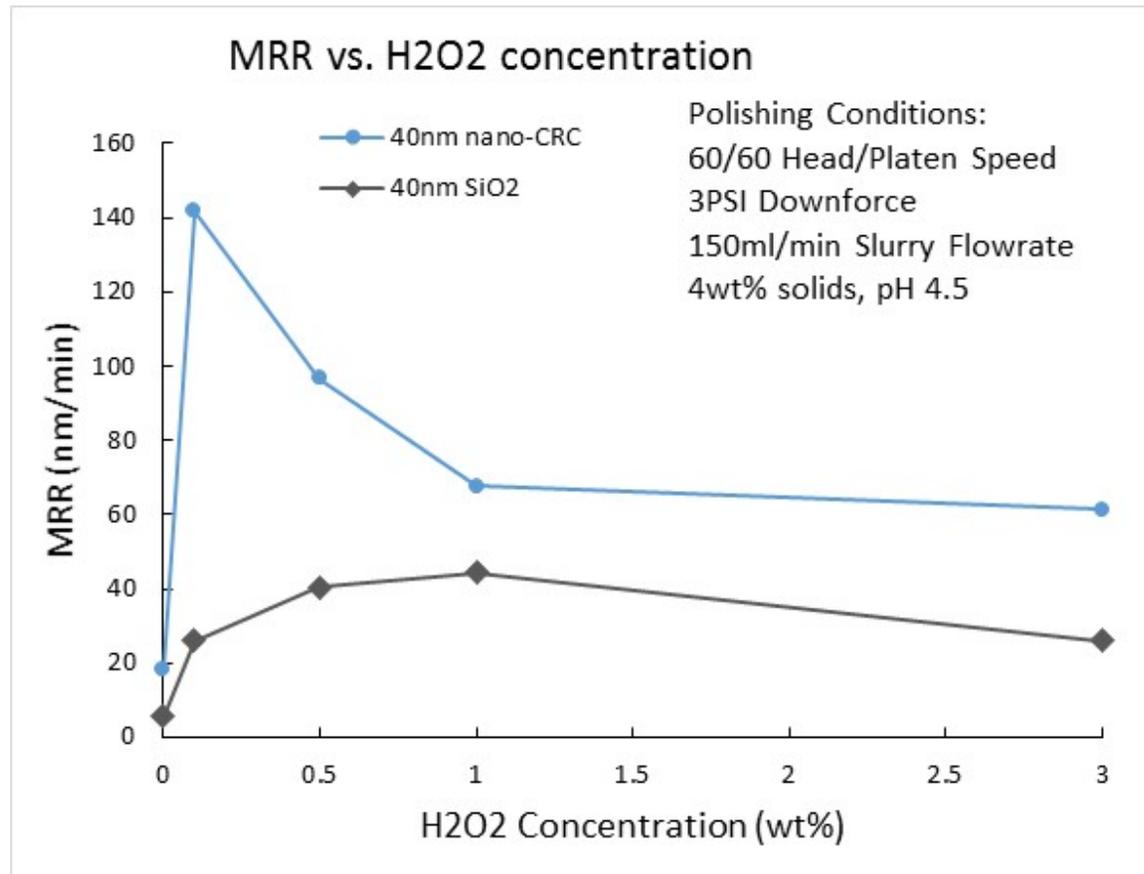
Slurry	MRR (nm/min)
40nm SiO <sub>2</sub> – not coated	44
40nm SiO <sub>2</sub> – polymer coated + 5wt% Glycine	43
40nm SiO <sub>2</sub> – polymer coated + 10wt% Glycine	65
40nm SiO <sub>2</sub> – polymer coated + 15wt% Glycine	94
40nm SiO <sub>2</sub> – polymer coated + 22wt% Glycine	134

**Polishing conditions: IC1000  
polishing pad, 60rpm platen  
speed/60rpm head speed,  
150ml/min slurry delivery,  
3PSI downforce.**

- Glycine concentration  
limited by solubility in H<sub>2</sub>O

# Cu CMP Data

- CMP of 6in blanket copper wafers on Strasbaugh 6EC CMP machine



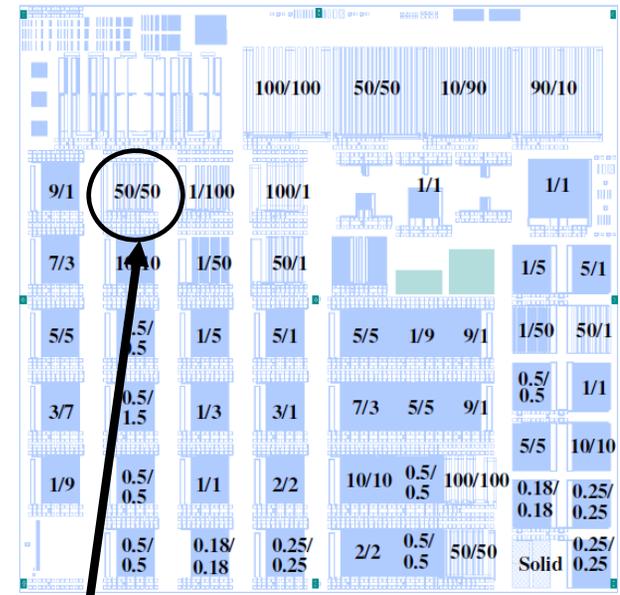
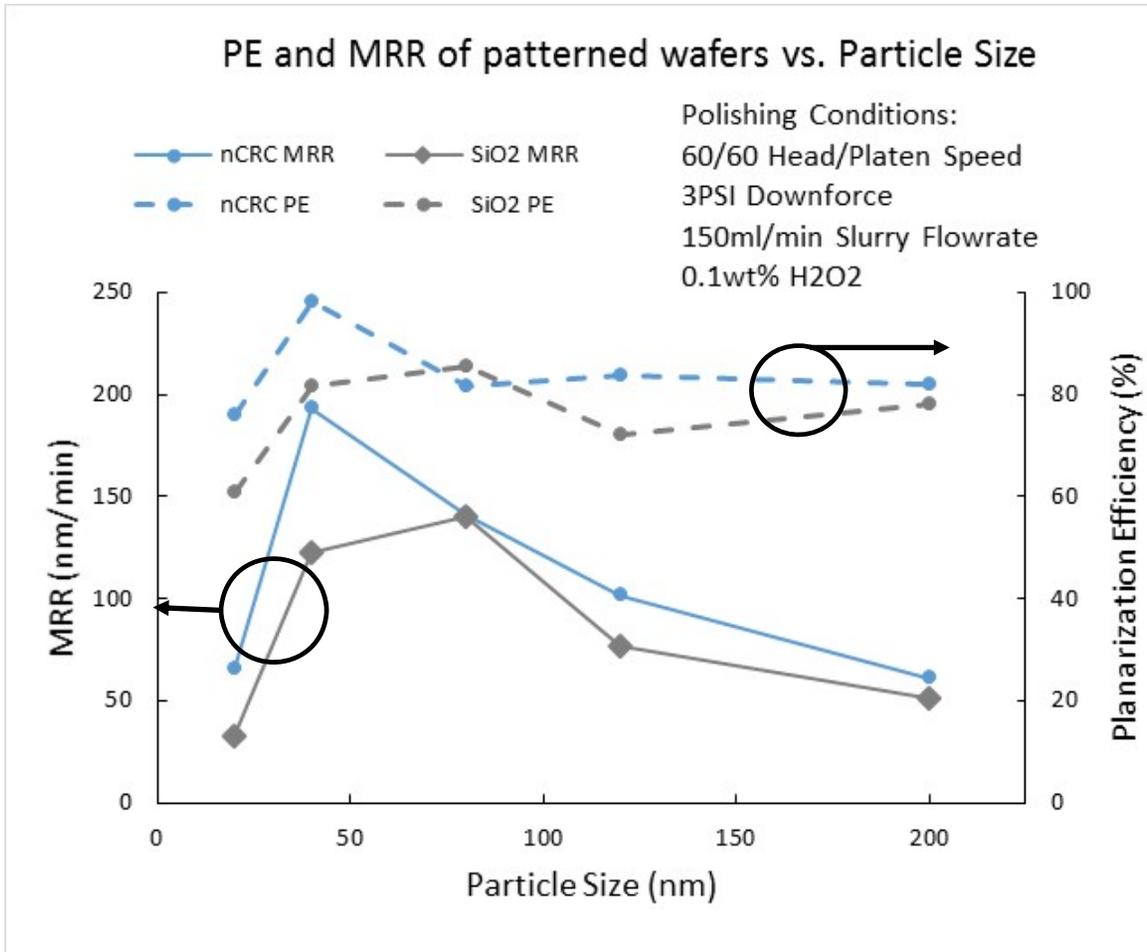
Nano-CRC slurry – 40nm Silica nanoparticles loaded with **glycine** and polymer coated

40nm SiO2 slurry – 40nm Silica nanoparticles (no chemistry or coating)

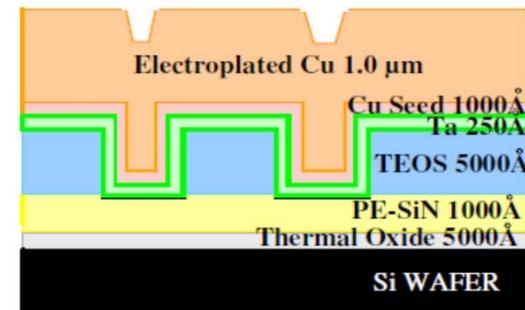
❑ Nano-CRC - very sensitive to H2O2 concentration!

❑ Optimal H2O2 concentration ~0.1wt%

# Cu CMP Data – Patterned Wafers



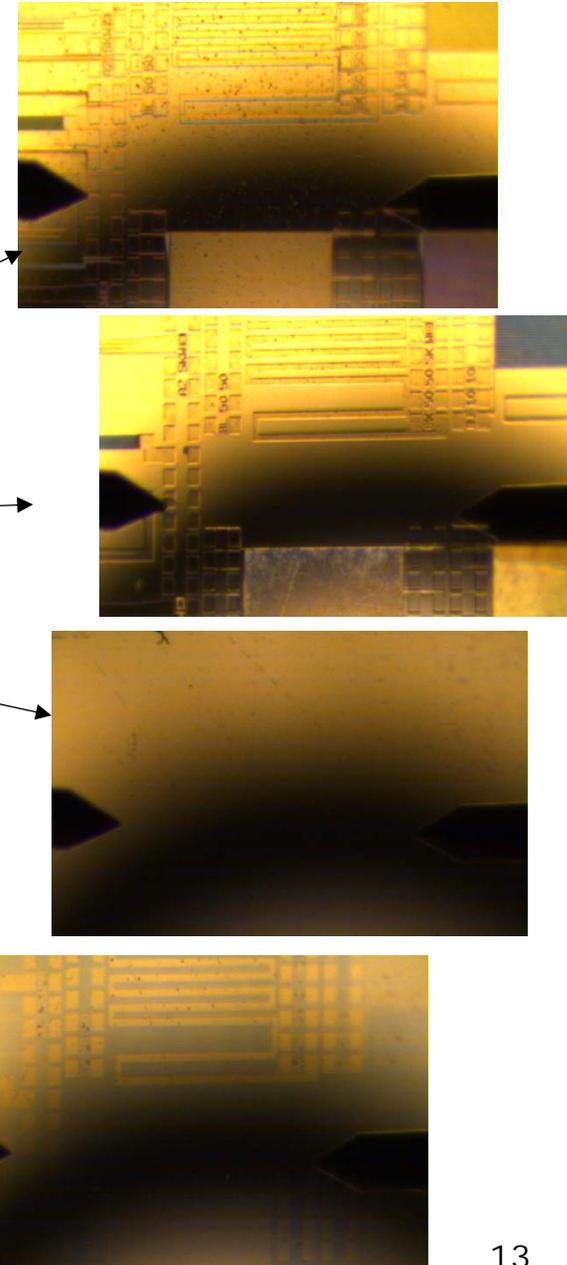
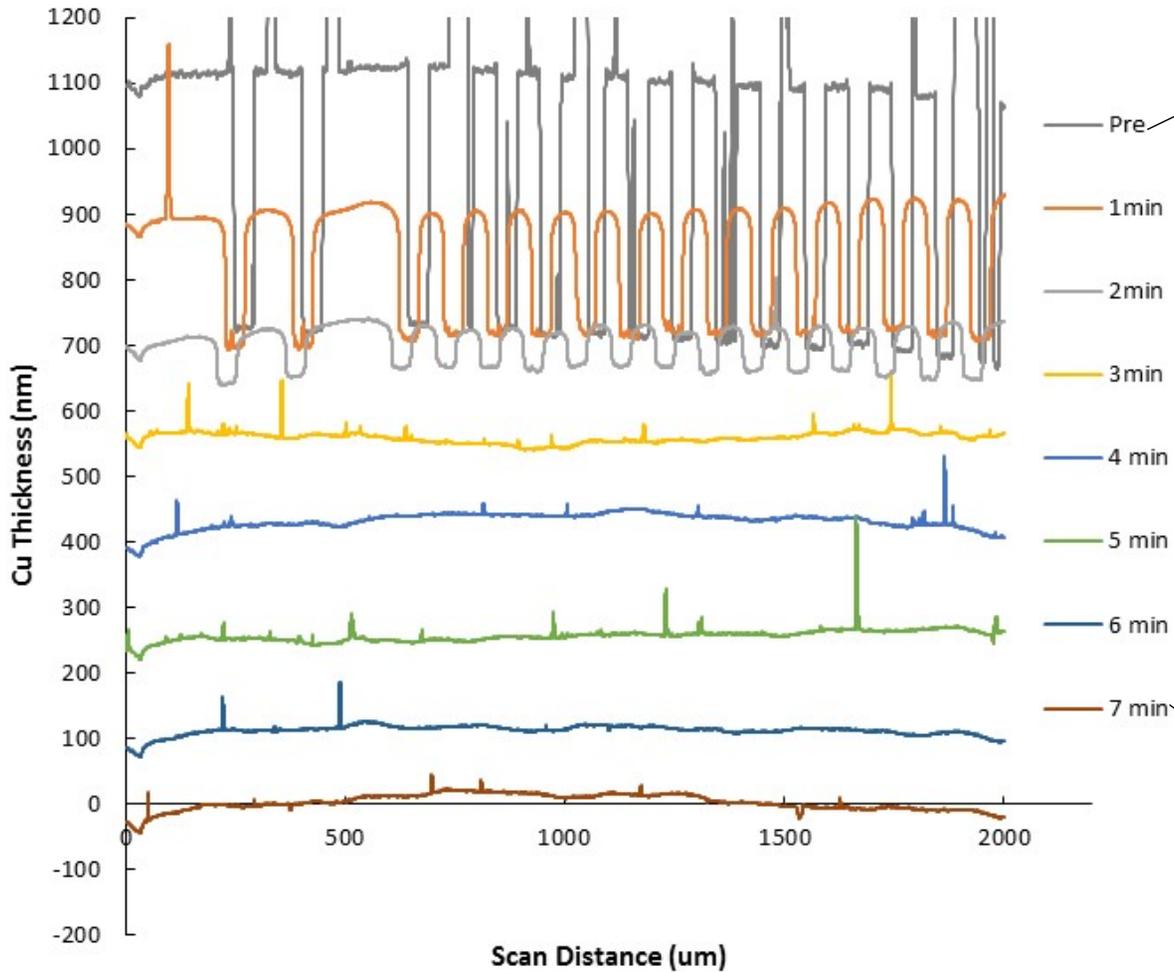
Profile of 50um line space/50um line width feature used to determine PE.



- ❑ Highest PE and MRR - 40nm Nano-CRC Slurry
- ❑ Porosity/Loading changes with PS?

# Cu CMP Data – Patterned Wafers

Profile of Middle Site on Patterned Cu wafer before and after CMP using Nano-CRC slurry at pH 4.5 (4wt% 40nm Silica loaded with Glycine and polymer coated , 0.1wt% H<sub>2</sub>O<sub>2</sub>, 1mmol KNO<sub>3</sub>)



□ 40nm Nano-CRC Slurry PE>85%

# Other Efforts

- ❑ Chemical Payloads
  - ❑ Silica – Glycine, Tartaric Acid, acetic acid, potassium persulfate, – all successfully loaded.
- ❑ Increasing/controlling the porosity of silica nanoparticles
  - ❑ Payload concentration limited by solubility and porosity
  - ❑ 80nm SiO<sub>2</sub> particles highest MRR but no increase in MRR in nano-CRC form - low porosity?
- ❑ Base particles – Colloidal Properties (IEP) limit particle effectivity
  - ❑ Commercially available - SiO<sub>2</sub>, CeO<sub>2</sub>, Al<sub>2</sub>O<sub>3</sub>
  - ❑ Low cost Composite Nanoparticles ?

**Other nano-capsules  
– Bring us your ideas!**

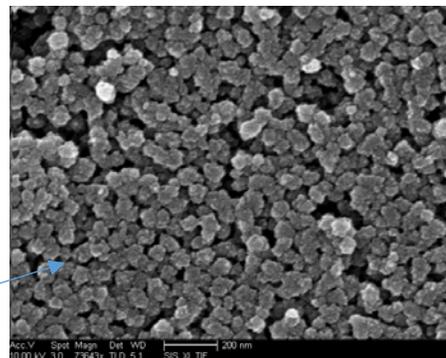
MRR for Ti CMP with nano-CRC

Slurry	MRR (nm/min)
40nm SiO <sub>2</sub> – not coated	44
40nm SiO <sub>2</sub> – polymer coated + 4wt% K <sub>2</sub> S <sub>2</sub> O <sub>8</sub>	118

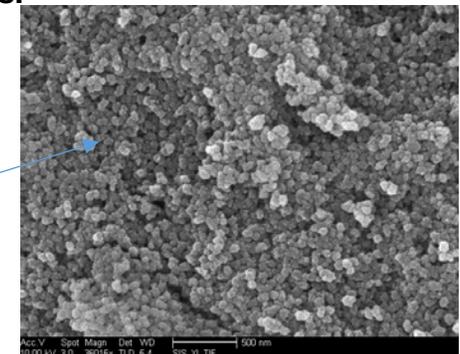
Measured IEP for various nanomaterials synthesized using GE&R proprietary methods.

Material	Measured IEP
SiO <sub>2</sub>	2
Si-Al-O	4-5
Al-O	8-9

Material	Measured IEP
SiZrO <sub>4</sub>	3-4
Si <sub>0.5</sub> Zr <sub>1.5</sub> O <sub>4</sub>	4-5
ZrO <sub>2</sub>	5-6



Material	Measured IEP
SiO <sub>2</sub>	2
SiTiO <sub>4</sub>	2-3
Si <sub>0.5</sub> Ti <sub>1.5</sub> O <sub>4</sub>	3-4
Si <sub>0.2</sub> Ti <sub>1.8</sub> O <sub>4</sub>	3-4
TiO <sub>2</sub>	~4



**Tunable IEP Nanocomposites - Spherical Morphology – low defectivity**

# Summary

- ❑ High quality monodispersed silica nanoparticles commercially available
- ❑ Processing techniques to form high quality nano-capsule slurries developed
- ❑ Advantages of nano-Capsule slurries
  - ❑ High planarization efficiencies
  - ❑ Enables controlled exposure of chemicals to surface
  - ❑ Environmental – low concentrations of toxic/hazardous payloads possible

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## Contact Information

Robin Ihnfeldt, Ph.D.  
(858) 736-5069  
[rihnfeldt@geandr.com](mailto:rihnfeldt@geandr.com)

<http://geandr.com/>